Product data sheet

1. General description

WSJM65R099DW is a high voltage N-channel MOSFET in TO247 package, which utilizes the advanced super-junction technology to provide superior FOM $R_{\rm DS(on)}{}^{*}$ $Q_{\rm g}$ among silicon based MOSFETs. It is particularly suitable for applications require extreme high efficiency and power density.



2. Features and benefits

- Superior FOM R_{DS(on)} * Q_g
- Extremely low switching loss
- · Integrated ultrafast body diode
- 100% avalanche tested

3. Applications

- EV charger
- · High efficiency power supplies
- On board charger
- Inverters

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes		Values		Unit	
Absolute	Absolute maximum rating							
V _{DS}	drain-source voltage				650		V	
V_{GS}	gate-source voltage				±30		V	
I _D	continuous drain current	T _{mb} = 25 °C			32		Α	
P _{tot}	power dissipation	T _{mb} = 25 °C			240		W	
T _j	junction temperature			-55 to 150		°C		
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit	
Static cha	aracteristics		,					
R _{DS(on)}	drain-source on-state resistance	V _{GS} = 10 V, I _D = 16 A		-	82	99	mΩ	
Dynamic	Dynamic characteristics							
Q _{G(tot)}	total gate charge	I _D = 16 A; V _{DS} = 400 V; V _{GS} = 10 V		-	57	-	nC	
E _{oss}	coss stored erergy	V _{GS} = 0 V; V _{DS} = 0 to 400 V		-	7	-	μJ	

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		ID.
2	D	drain	ЩОЩ	D
3	S	source		G (F)
mb	D	mounting base; connected to drain	1 2 3	sym302 S

6. Ordering information

Table 3. Ordering information

Type number	Package name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WSJM65R099DW	TO247	WSJM65R099DWQ	Tube	30	TO247N	20-July-2016

7. Marking

Table 4. Marking codes

•	
Type number	Marking codes
WSJM65R099DW	WSJM 65R099DW

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V _{DS}	drain-source voltage			650	V
V _{GS}	gate-source voltage			±30	V
I _D	continuous drain current	T _{mb} = 25 °C		32	Α
		T _{mb} = 100 °C		20	Α
I _{DM}	pulsed drain current	T _{mb} = 25 °C		128	Α
P _{tot}	power dissipation	T _{mb} = 25 °C		240	W
E _{AS}	single pulse drain-to- source avalanche	I_{AS} = 6.4 A; R_{GS} = 25 Ω ; V_{DD} = 50 V; T_{j} = 25 °C		204	mJ
E _{AR}	repetitive avalanche energy	$I_{AS} = 6.4 \text{ A}; R_{GS} = 25 \Omega; V_{DD} = 50 \text{ V};$ $T_j = 25 \text{ °C}$		0.72	mJ
I _{AS}	avalanche current, single pulse			6.4	А
dv/dt	MOSFET dv/dt ruggedness			64	V/ns
dv/dt	reverse diode dv/dt			50	V/ns
dl _F /dt	maximum diode commutation speed			850	A/µs
T _{stg}	storage temperature			-55 to 150	°C
T _j	junction temperature			-55 to 150	°C

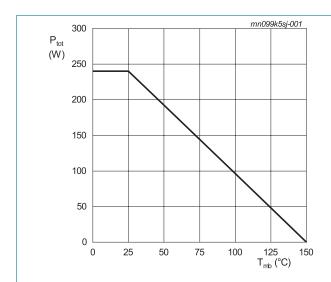


Fig. 1. Normalized total power dissipation as a function of mounting base temperature

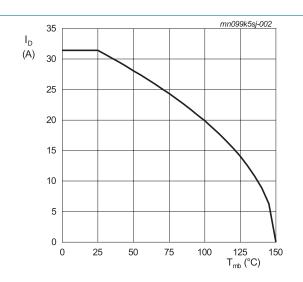


Fig. 2. Continuous Drain Current as a function of mounting base temperature

9. Thermal & Mechanical characteristics

Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{\text{th(j-mb)}}$	thermal resistance from junction to mounting base			-	0.4	0.52	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	in free air		-	45	-	K/W

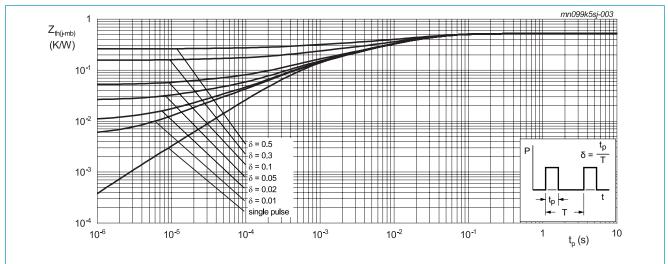


Fig. 3. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

Table 7. Characteristics

T_i = 25 °C unless otherwise noted

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 1 \text{ mA}; V_{GS} = 0 \text{ V}$		650	-	-	V
$V_{\text{GS(th)}}$	gate-source threshold voltage	$I_D = 250 \ \mu A; \ V_{DS} = V_{GS}$		3	-	5	V
I _{DSS}	drain leakage current	$V_{DS} = 650 \text{ V}; V_{GS} = 0 \text{ V}$		-	-	10	μA
		$V_{DS} = 650 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 ^{\circ}\text{C}$		-	100	-	μA
I _{GSS}	gate leakage current	$V_{GS} = \pm 30 \text{ V}; V_{DS} = 0 \text{ V}$		-	-	±500	nA
$R_{\text{DS(on)}}$	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 16 \text{ A}$		-	82	99	mΩ
R_{G}	gate resistance	f = 1 MHz		-	32	-	Ω
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	$I_D = 16 \text{ A}; V_{DS} = 400 \text{ V}; V_{GS} = 10 \text{ V}$		-	57	-	nC
Q _{GS}	gate-source charge			-	16	-	nC
Q_{GD}	gate-drain charge			-	22	-	nC
C _{iss}	input capacitance	V _{DS} = 400 V; V _{GS} = 0 V; f = 250 kHz		-	2797	-	pF
C _{oss}	output capacitance			-	44	-	pF
C _{rss}	reverse transfer capacitance			-	1.6	-	pF
C _{o(er)}	effective output capacitance, energy related	$V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$		-	88	-	pF
$C_{o(tr)}$	effective output capacitance, time related			-	731	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 400 \text{ V}; V_{GS} = 10 \text{ V}; R_G = 2 \Omega;$		-	129	-	ns
t _r	rise time	I _D = 16 A		-	15	-	ns
$t_{d(off)}$	turn-off delay time			-	225	-	ns
t _f	fall time			-	9.1	-	ns
Source-d	rain diode						
V_{SD}	source-drain voltage	V _{GS} = 0 V; I _S = 16 A		-	0.94	1.2	V
I _s	body-diode continuous current	T _{mb} = 25 °C		-	-	32	А
t _{rr}	reverse recovery time	$V_R = 400 \text{ V}; I_F = 16 \text{ A}; dI_F/dt = 100 \text{ A/}\mu\text{s}$		-	142	-	ns
Q _{rr}	reverse recovered charge			-	1	-	μC
I _{rrm}	reverse recovery current			-	14	-	Α

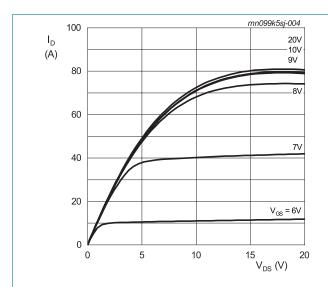
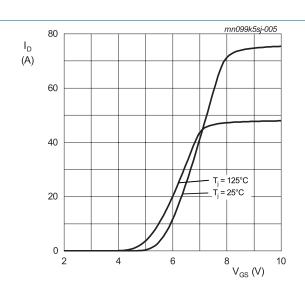
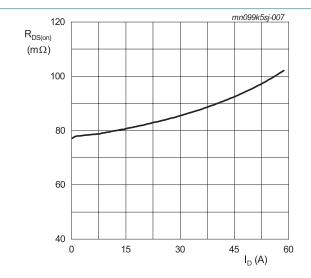


Fig. 4. Drain current as a function of drain-source voltage; typical values

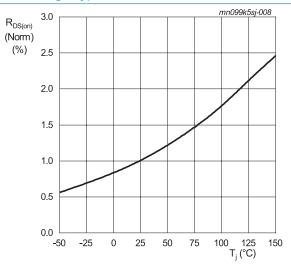


V_{DS} = 20 V

Fig. 5. Drain current as a function of gate-source voltage; typical values



V_{GS} = 10 V
Fig. 6. Drain-source on-state resistance as a function of drain current; typical values



V_{GS} = 10 V; I_D = 16 A

Fig. 7. Normalized drain-source on-state resistance as a function of junction temperature

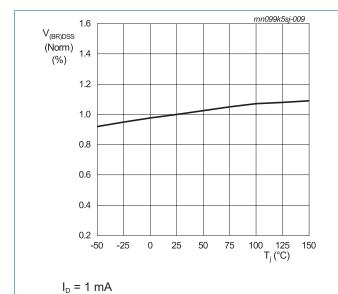
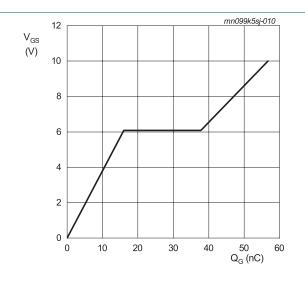
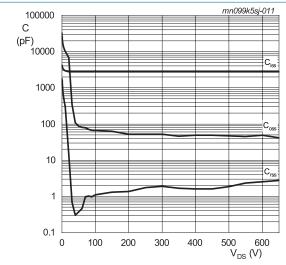


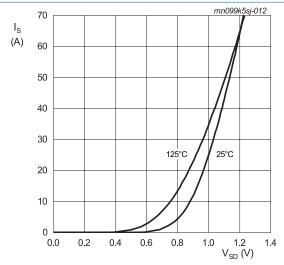
Fig. 8. Normalized drain-source breakdown voltage as a function of junction temperature



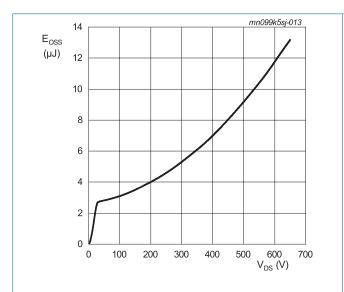
I_D = 16 A; V_{DS} = 400 V Fig. 9. Gate-source voltage as a function of gate charge; typical values



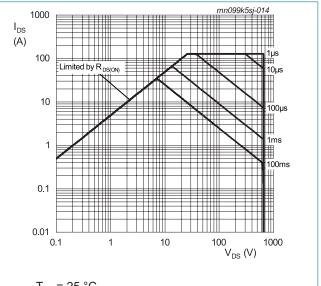
V_{GS} = 0 V; f = 250 kHz Fig 10. Capacitances as a function of drain-source voltage; typical values



V_{GS} = 0 V Fig 11. Source current as a function of source-drain voltage; typical values

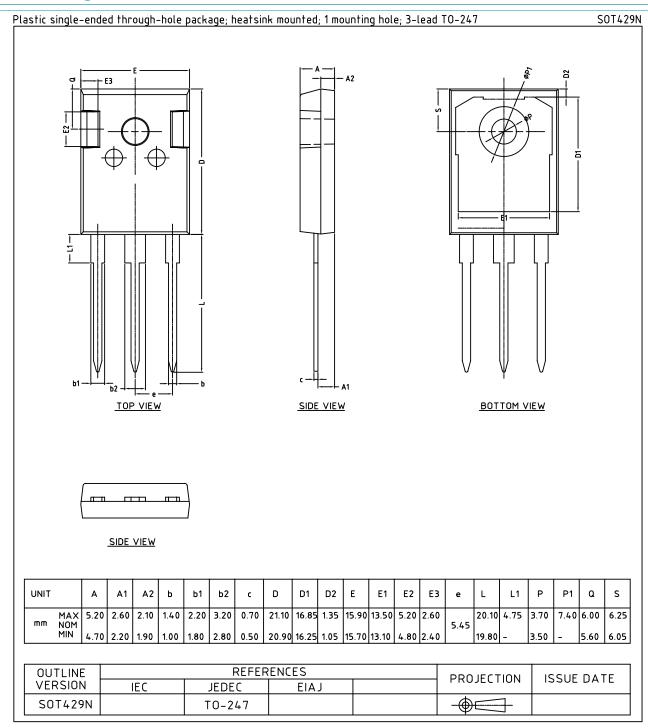






 T_{mb} = 25 °C Fig. 13. Safe operating area

11. Package outline



12. Legal information

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Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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